

# AAEON

**AAEON Technology INC.**  
ISO-9001/ISO-14001 Certified  
Industrial Automation PCs

## **AEC-6000 EVT**

# **Temperature Test Report**

**Release Date : Jun/26/2001**

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**Issue Stamp**

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**QA Manager**

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**QE Manager**

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**Test Engineer**

# Environment

**Model Name :** AEC-6000 EVT

**Test Date :** 06-26-2001

**Test Site :** AAEON QE Dept.

**Performed by :** Rex Chang

**Test Standard :**

Select	NO.	Description
√	IEC 68-2-61	Test Z/ABD : Climatic Sequence Test

**Testing Item :**

Temperature & Humidity Cycle

**Additional Test Peripheral :**

Configuration	Model
Test Software	Run QAPLus 5.5

**Testing Equipment :**

Programmable Temperature & Humidity Chamber

Model : Ths-D4L+-100

S/N : 1241

Date of Calibration : 07-10-1998

**Sample Configuration & Quantity Under Test :**

**System Information :**

**Chassis :**

**AEC-6000**

**System :GENE-4310**

**1.Chipset: NS Geode CS5530A**

**2.CPU: NS NS Geode GX1-233**

**3.Memory: 32M SDRAM ( NEC D4564163G5 )**

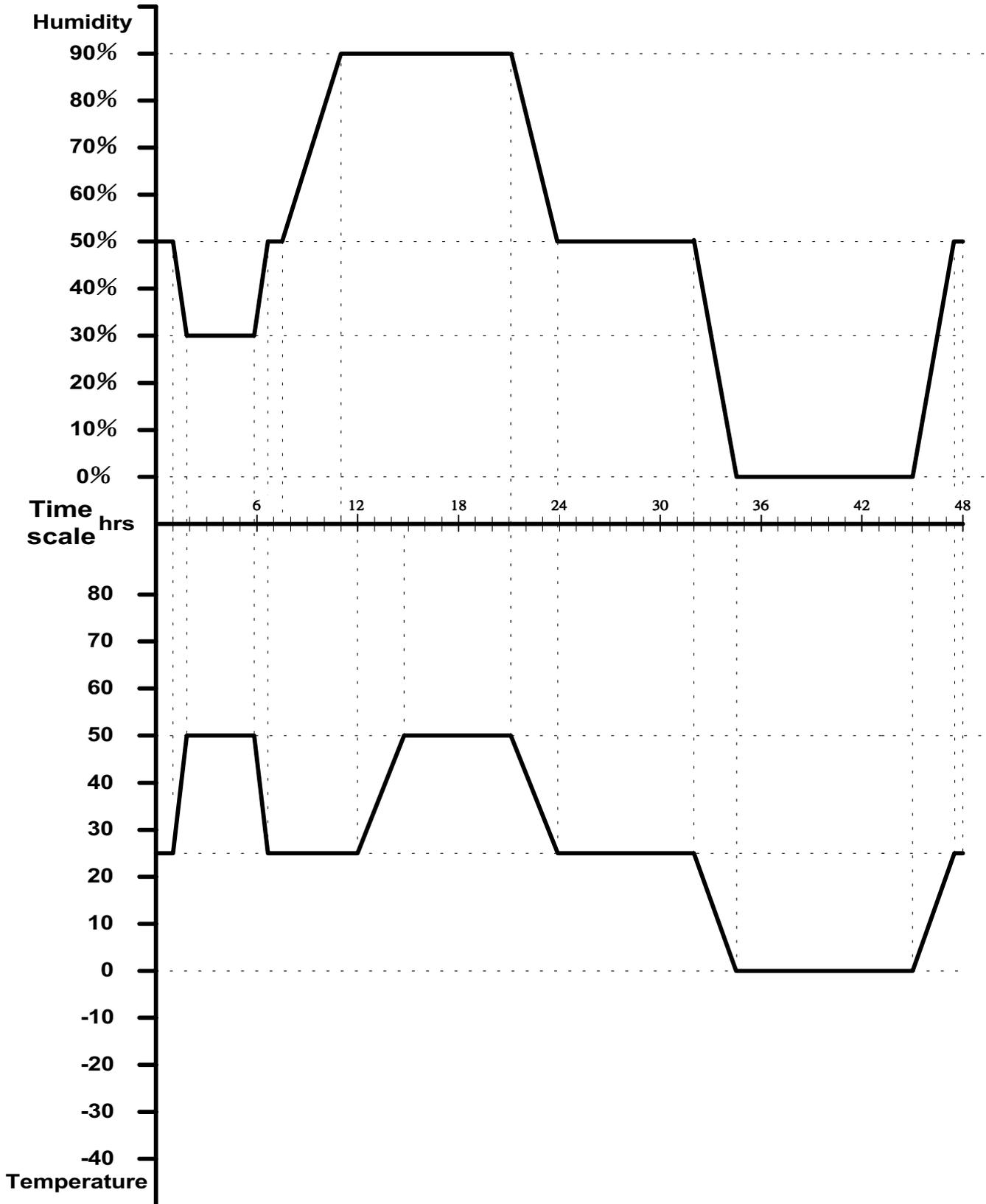
**4.VGA: NS Geode CS5530A**

**Test Result :**

Standard	Description	Result
IEC 68-2-61	Temperature & Humidity Cycle Test (Run QAPLusfe 5.5)	Pass

# Environment

Temperature & Humidity Cycle Test(Run QAPlusfe 5.5)



# Environment

Temperature & Humidity Cycle Test(Run QAPlusfe 5.5)

